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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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## FOREIGN PATENT DOCUMENTS

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	N					
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## **NON-PATENT DOCUMENTS**

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	J. L. Liotard et al., "Intermetallic Compound Formations in tianium-copper thin-film couples", Journal of Applied Physics, vol. 57, issue 6, March 15, 1985, pp 1895-1900.		
	v			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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